



Combined Form PTO/SB/08A&B INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)				Complete if Known	
				Application Number	10/577,490
				Confirmation Number	5105
				Filing Date	April 27, 2006
				First Named Inventor	Shoji KAWAHITO et al.
				Art Unit	2819
				Examiner Name	Peguy Jean Pierre
Sheet	1	of	1	Attorney Docket Number	062487

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
		Number	Kind Code ² (if known)		
	1	US 2003/0001075	A1	01-02-2003	Mukherjee et al.
	2	US 5,644,313	A	07-01-1997	Rakers et al.
		US			
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FOREIGN PATENT DOCUMENTS							
Examiner Initials*	Cite No. ¹	Foreign Patent Document			Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Translation ⁶
		Country Code ³	Number ⁴	Kind Code ⁵ (if known)			
	3	JP	2002-261613	A	09-13-2002	Fujita Kazuki	Abstract

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city, and/or country where published.	Translation ⁶
	4	STEVEN DECKER et al.: "A 256 CMOS Imaging Array with Wide Dynamic Range Pixels and Column-Parallel Digital Output" IEEE JOURNAL OF SOLID-STATE CIRCUITS, IEEE SERVICE CENTER, PISCATAWAY, NJ, US, vol. 33, no. 12, December 1998.	
	5	GARRITY D et al.: "A 10 bit, 2Ms/s, 15 mW BiCMOS cyclic RSD A/D converter" BIPOLAR/BICMOS CIRCUITS AND TECHNOLOGY MEETING, 1996., PROCEEDING OF THE 1996 MINNEAPOLIS, MN, USA 29 SEPT -1 OCT 1, NEW YORK, NY, USA, IEEE, US, 29 September 1996, PAGES 192-195.996	
	6	Supplementary European Search Report dated September 25, 2006, issued in corresponding European Patent Application Number 04 79 3319.7.	

Examiner Signature		Date Considered	
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Applicant's unique citation designation number (optional). ²See Kind Codes of USPTO Patent Documents at www.uspto.gov, MPEP 901.04 or in the comment box of this document. ³Enter Office that issued the document, by the two-letter code (WIPO Standard ST. 3). ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶Applicant is to indicate here if English language Translation is attached.